

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10576386	SINGH ET AL.
	Examiner	Art Unit
	Loewe, Sun Jae Y	1626

SEARCHED

Class	Subclass	Date	Examiner
548	492	7-28-2008	sl
514	419	7-28-2008	sl

SEARCH NOTES

Search Notes	Date	Examiner
stn structure search	11-28-2007	sl
palm all inventors	11-28-2007	sl
STN: updated registry & caplus	5-12-2008	sl
PALM all inventors updated	5-12-2008	sl
STN: registry & caplus updated	7-28-2008	sl
PALM all inventors updated	7-28-2008	sl
Patentability Conference (K. Saeed, J. McKane)	7-29 & 7-31-2008	sl

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
548	492	7-28-2008	sl
514	419	7-28-2008	sl